# AARTS Automated Accelerated Reliability Test Systems

# Family of Testers Automates & Accelerates Life Testing

AARTS fully integrated, automated, turnkey system provides flexibility and accuracy in determining RF and DC performance degradation with aging to predict life expectancy for compound semiconductor devices.

## A single system to simultaneously ...

- Determine life expectancy of compound semiconductor components
- Characterize components during test to show RF and DC degradation with age

## **Multidimensional Dynamic Testing**

- Automatically perform 3-temperature life tests
- Automatically characterize components

## **Aggregate Analysis Tools**

- Supports generic SPA sweep, Gain Compression, and Stress data extraction
- Arrhenius, Lognormal, Weibull and Exponential models available

## Stimulate each DUT with ...

#### RF

- · Independent RF drive level for each DUT
- Frequency ranges to 77GHz and RF input up to 50W

#### DC

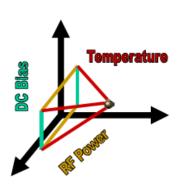
- Two indpendent bias sources (up to 100V, 4A at 200W max)
- Bias can be constant voltage or constant current sources

#### **Temperature**

- Independent "Channel" or "Surface" temp control for each DUT
- +50°C to +300°C

# Testing Tomorrow's Technology Today







Capacity: 72, 96 channels Setup & Control	20 KVA Serial		
<b>Capacity:</b> 4, 8, 24 channels <b>Capacity:</b> 16, 36, 48, 60 channels	5 KVA 10 KVA	Nitrogen (N2) Input	Connect to a 1/4" Swagelok®
(UPS)	E I/A/A	Double-Rack Triple-Rack	3.5 KW
Setup & Control Uninterruptible Power Supply	GPIB	Peak Power Single-Rack	
Туре	Keysight/Keithley Unit Compatible	Deals Dayser	230/400 VAC, 50 amp, 50/60 Hz
er (SPA) Independent Channels	up to 96 multiplexed	Triple-Rack	120/208 VAC, 60 amp, 50/60 Hz
Semiconductor Parameter Analyz-		Double-Rack	
Switch Matrix Unit (SMU) Indpendent Channels Setup & Control	up to 96 (Triaxial) GPIB	Power Single-Rack	120/208 VAC, 30 amp, 50/60 Hz 230/400 VAC, 20 amp, 50/60 Hz
Shutdown Setup & Control	Within 1usec GPIB	Double-Rack Triple-Rack	415kg / 917lbs typical 2-bay 635kg / 1375lbs typical 3-bay
Bias 2 Driven	-12V to +12V; up to 0.5A	Weight Single-Rack	210 kg / 458lbs typical 1-bay
Bias 1	0.5V to 100V; up to 3A - (Pmax = 200W)	Triple-Rack (96 Channels)	171 x 140 x 91 cm
Independent Channels	Two bias supplies per channel	Double-Rack (16, 48, 60, 72 Channels)	114 x 140 x 91 cm
DC Power Control Unit (PCU)	contact factory)	Physical Characteristics (Size) Single Rack (4, 8, 24, 36 Channels)	57 x 140 x 91 cm
Independent Channels Power per DUT	up to 16 Up to 50 watts (frequency dependent -	Operating System	
Setup & Control Solid State Power Aplifiers (SSPA)	GPIB	Mass Storage Monitor	17" diagonal color LCD
DUT Input Level Adjust	>40 dB `	Network Support	PCI 10/100
Input Power per DUT Output Power per DUT	+15 dBm (without SSPA) 45dBm (30 watts)	Personal Computer (Rackmount) System Control	PCI GPIB
RF Distributor Unit (RFU) Independent Channels	up to 16	Online Reference	extraction and analysis Reliability Assurance Guideline
Setup & Control	GPIB	Data Analysis	Activation energy and SPA parameter
Heater Control Unit (HCU) Independent Channels	up to 32	Network Support	
Range Sensor	+50° to +300° C (under no load) Thermocouple per DUT fixture	Data & Status Displays	Multi-channel grid; single-channel composite; plot; SPA I-V curve; event log
Accuracy	+/- 2°C		sequence, UPS shutdown, low gas pressure, disk usage, etc.
RF & DC	Any die, standard packages or custom design	Data Storage Rates: Accelerated Alarm Notification	Display & email: device shutdown, test
DUT Configuration	7 10 00	Data Storage Rates: Normal	User defined rate
Max RF Output Power per DUT DUT RF Input Level Adjustment	30 watts	DUT Data Logging Data Storage	
Max RF Input Power per DUT	+20 dBm (typical) +15 dBm (minimum)	Limit Checking	
	2 GHz to 18 GHz Millimeter-wave bands avialable)	Calibration	input and output signals Automated calibration of temperature,
J	900 MHz to 12GHz	Conrtol	DUT temperature, 2-DC biases, RF
DC RF Ranges	24, 36, 48, 60, 72, 96 600 MHz to 3GHz		DC, RF, temperature and over 40 parameters of measurement
RF	4, 8, 16	Setup	test scenario for each DUT. Includes:
Versions Simultaneous DUTs per system		Application Software Setup	Pull down menus w/ forms that define